Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/533,280	LIN, JIE
Examiner	Art Unit
Tuan H. Nguyen	2618

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	13.4, 522	7/8/2006	T.N
-			

INTERFERENCE SEARCHED			CE SEARCHED	
Class	Subclass	Date	Examiner	
			-	

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
All searches are on EAST data base.	7/8/2006	T.N